HUL7254

Hologram unit for CD/CD-ROM drive

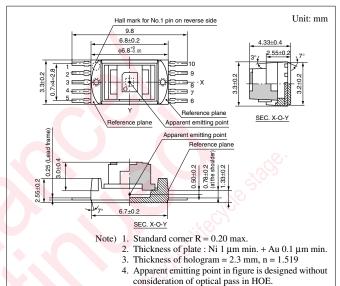
For optical information processing

■ Features

- Semiconductor laser and photodetector are integrated through using micro-mirror.
- Focus error signal detection: SSD method
- Tracking error signal detection: 3-beam method
- Low-power semiconductor laser included
- Built-in I-V conversion amplifier

Applications

• CD-ROM drive (slim type)

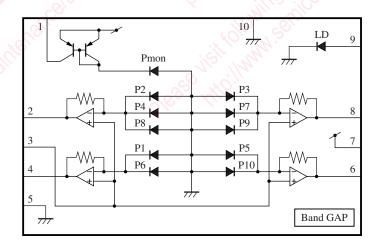


■ Absolute Maximum Ratings

Parameter	Symbol	Rating	Unit	
Laser beam output	Po	3.6	mW	
Laser reverse voltage	V _{R(LD)}	2	V ₀	
Supply voltage *	V _{CC}	6	V	
Reference voltage	$V_{\rm C}$	$+1.3$ to $V_{CC} - 1.3$	© v 🔏	
Operating ambient temperature	T _{opr}	-10 to +60	°C	
Storage temperature	T_{stg}	-40 to +85	9 °C	

Note) *: Recommended supply voltage is 4.5 V to 5.5 V.

■ Block Diagram



■ Pin Descriptions

Pin No.	Description	Pin No.	Description	
1	Mon. out	6	(P5 + P10) out	
2	(P2 + P4 + P8) out	7	V_{CC}	
3	V_{C}	8	(P3 + P7 + P9) out	
4	(P1 + P6) out	9	LD(+)	
5	GND	10	GND	

■ Electro-Optical Characteristics

• Unit characteristic specifications $T_C = 25^{\circ}C \pm 3^{\circ}C$

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Threshold current	I _{th}	CW	15	30	40	mA
Operating current	I _{OP}	$CW, V_{RF} = 570 \text{ mV}, V_{CC} = 5 \text{ V}$	20	35	48	mA
Operating voltage	V _{OP}	$CW, V_{RF} = 570 \text{ mV}, V_{CC} = 5 \text{ V}$.0	1.9	2.4	V
LD power intensity out of objective lens	P _{OP}	$V_{RF} = 570 \text{ mV}, V_{CC} = 5 \text{ V}$	C, III	0.18	0.30	mW
Focus error signal amplitude	V _{FE}	$V_{RF} = 570 \text{ mV}, V_{CC} = 5 \text{ V}$	340	480	620	mV
Tracking error signal amplitude	V _{TE}	$V_{RF} = 570 \text{ mV}, V_{CC} = 5 \text{ V}$	150	300	450	mV
Focus error signal defocus	D _{FO}	$V_{RF} = 570 \text{ mV}, V_{CC} = 5 \text{ V}$	-8		+8	%
Tracking error signal offset	B _{TE}	$V_{RF} = 570 \text{ mV}, V_{CC} = 5 \text{ V}$	-30		+30	%
Jitter	Jitter	$V_{RF} = 570 \text{ mV}, V_{CC} = 5 \text{ V}$			6	ns

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GaAs powder and vapor are hazardous to human health if inhaled or ingested. Do not burn, destroy, cut, cleave off, or chemically dissolve the product. Follow related laws and ordinances for disposal. The product should be excluded from general industrial waste or household garbage.

■ Do not touch or look into the laser beam directly.

The laser beam may cause injury to the eye or skin, or loss of eyesight.

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